ANALOG Product/Process Change Notice - PCN 12_0237 Rev. -

Analog Devices, Inc. Three Technology Way Norwood, Massachusetts 02062-9106

This notice is to inform you of a change that will be made to certain ADI products (see Material Report). Any issues with this PCN or requirements to qualify the change (additional data or samples) must be sent to ADI within 30 days of publication date. ADI contact information is listed below.

PCN Title:	AD8203 Minor Die Revision and Datasheet Change		
Publication Date:	05-Nov-2012		
Effectivity Date:	03-Feb-2013	(the earliest date that a customer could expect to receive changed material)	

Revision Description:

Initial Release

Description Of Change

1. Increasing polyimide overcoat thickness from 7um to 19um for the wafer fabrication process of the AD8203.

2. Reallocate the use of existing pads on Met1 for use as Kelvin pads which will be connected to the input pins (pins 1 and 8).

3. Remove Min/Max limits rated at 25C (system gain, common mode & voltage offset) from specification table on page 3 and replace with Min/Max limits over the entire temperature range.

Reason For Change

1. Additional polyimide thickness reduces die sensitivity to package stress.

2. Reallocating the use of existing pads on Met1 for use as Kelvin pads will allow the trim process to give increased accuracy of offset voltage, common mode, and gain.

Updating the datasheet to specify Min/Max limits over the entire temperature range reflects the current ADI practice for specifying products used by automotive customers.

Impact of the change (positive or negative) on fit, form, function & reliability

The additional polyimide thickness and kelvin pads applied to the AD8203 will not affect the fit, form or function of the device. The performance of the part will continue to match the specifications in the datasheet. Data sheet changes will have no effect on production flow or test limits.

Summary of Supporting Information

Qualification has been performed per AEC-Q100, Stress Test Qualification for Integrated Circuits. See attached Qualification Report Summary.

Supporting Documents

Attachment 1: Type: Qualification Report Summary

Attachment 2: Type: Revised Datasheet Specification

ADI_PCN_12_0237_Rev_-_AD8203_Preliminary_Rev_C.pdf

	For questions on this PCN, send email to the regional contacts below or contact your local ADI sales representative					
Americas:	PCN_Americas@analog.com	Europe:	PCN_Europe@analog.com	Japan: Rest of Asia:	PCN_Japan@analog.com PCN_ROA@analog.com	

Appendix A - Affected ADI Models					
Added Parts On This Revision - Product Family / Model Number (8)					
AD8203 / AD45097	AD8203 / AD45099	AD8203 / AD8203YRMZ	AD8203 / AD8203YRMZ-R7	AD8203 / AD8203YRMZ-RL	
AD8203 / AD8203YRZ	AD8203 / AD8203YRZ-R7	AD8203 / AD8203YRZ-RL			

Appendix B - Revision History				
Rev	Publish Date	Effectivity Date	Rev Description	
Rev	05-Nov-2012	03-Feb-2013	Initial Release	

Analog Devices, Inc.

Docld:2113 Parent Docld:1775 Layout Rev:7